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A Single-Terminal Fault Location Method for HVDC Transmission Lines Based on a Hybrid Deep Network

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Abstract: High voltage direct current (HVDC) transmission systems play an increasingly important role in long-distance power transmission. Realizing accurate and timely fault location of transmission lines is extremely important for the safe operation of power systems. With the development of modern data acquisition and deep learning technology, deep learning methods have the feasibility of engineering application in fault location. The traditional single-terminal traveling wave method is used for fault location in HVDC systems. However, many challenges exist when a high impedance fault occurs including high sampling frequency dependence and difficulty to determine wave velocity and identify wave heads. In order to resolve these problems, this work proposed a deep hybrid convolutional neural network (CNN) and long short-term memory (LSTM) network model for single-terminal fault location of an HVDC system containing mixed cables and overhead line segments. Simultaneously, a variational mode decomposition–Teager energy operator is used in feature engineering to improve the effect of model training. 2D-CNN was employed as a classifier to identify fault segments, and LSTM as a regressor integrated the fault segment information of the classifier to achieve precise fault location. The experimental results demonstrate that the proposed method has high accuracy of fault location, with the effects of fault types, noise, sampling frequency, and different HVDC topologies in consideration.



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Keywords: HVDC systems; fault location; fault segment identification; CNN-LSTM; VMD-TEO

1. Introduction

Renewable power generation has been widely used in recent years. High voltage direct current (HVDC) transmission systems can provide high power transmission capability over long distances. This technology is practical in the long-distance transmission of a large amount of wind power from ocean to land. Using submarine cables at sea and overhead lines on land is a practical method for connecting offshore wind farm stations with shore stations [1]. Owing to its long-distance transmission and complex natural environmental factors, the probability of line failures in this transmission system with mixed lines is high. Therefore, achieving timely and accurate fault location is a prerequisite for improving the reliable operation of the power system.

Fault location techniques can be divided into several categories, such as impedance-based, traveling wave-based, and machine learning-based methods [2]. Impedance-based methods [3] determine the fault distance via using fault voltage and current measurements from one or more terminals to calculate line impedance. These methods use a simplified equation for calculation by ignoring the capacitance and conductance of the transmission line to ground, which limits the accuracy of fault location [4]. Traveling wave-based methods determine the fault distance according to the reflection and refraction phenomenon of the voltage and current traveling wave at the fault point and terminals, and the traveling wave propagation speed [5,6]. Specifically, the single-ended traveling wave method does not require a global positioning system and communication equipment, showing a popular

application in the fault location of the HVDC system [7,8]. However, the challenge of this method is that it needs to accurately identify both the reflected and the initial traveling wave head, and determine traveling wave velocity [9]. Classical signal singularity detection methods, including wavelet transform (WT) [10,11], Hilbert–Huang transform (HHT) [12], and variational mode decomposition–Teager energy operator (VMD-TEO) [13,14], are adopted to solve the problem of traveling wave head identification. Traveling wave heads can be identified during low impedance fault (LIF). However, the traveling wave becomes extremely weak during high impedance fault (HIF), and identifying the wave head is difficult, thereby causing huge fault location errors [15]. In addition, the fixed aerial-mode traveling wave velocity was used for calculation in the traveling wave methods [10–14], but the actual velocity with a frequency variation characteristic is difficult to determine [16,17].

With the rapid development of artificial intelligence, machine learning has begun to be applied to various tasks in the electrical engineering field, such as load forecasting [18], optimal scheduling [19], fault diagnosis [20], etc. Machine learning-based methods are considered to be a tool for performing soft computing in fault location [21]. Shallow neural networks were used to distinguish fault locations considering different fault types [22]. In References [7,23], hybrid shallow machine learning and traveling wave methods were used for fault location. Support vector machine was first applied to distinguish the fault sections whether at the cable section or the overhead line section and whether at the front 1/2 or the back 1/2 of the line length of this section. Then fault distances were calculated. However, the methods in References [7,23] still need to obtain accurate traveling wave velocity and understand the complex laws of traveling wave propagation on transmission lines, especially considering the discontinuous wave impedance. Deep learning methods have become an effective means to complete fault location tasks without a lot of expert knowledge. The 1D-convolutional neural network (CNN) model [15] for double-terminal fault location overcomes difficulties in determining traveling wave velocity and identifying the wave head during HIF. However, the double-ended measuring devices increase the cost in actual engineering. In Reference [15], CNN's regression mechanism performed fault location. Its essence is similar to completing a task of time series forecasting. Recurrent networks, such as recurrent neural network (RNN) [24], long short-term memory (LSTM) [25], and gated recurrent unit (GRU) [26] are better than CNN in processing time series forecasting. The advantage of LSTM and GRU over RNN is that they can learn long-range-dependency time series. GRU is a simplified model of the LSTM structure, and its computational efficiency is higher than that of LSTM [26]. The bidirectional gated recurrent unit (Bi-GRU) can learn the characteristics of time series from both forward and reverse directions [27]. These recurrent networks as a regressor can be used for fault location. In Reference [21], Bi-GRU was used to identify faulty lines and locate faults in a distribution network. However, considering the unobvious identification of traveling wave characteristics caused by HIF, it may not be able to solve the problem of the scenario of considering large transition resistance.

The laws of refraction and reflection of traveling waves on actual HVDC transmission lines vary on different fault segments. This research is divided into two tasks including fault segment identification and precise fault location, which are the classification and the regression task, respectively. After the DC side line in the HVDC system fails, the voltage and current measured from the terminals will change. In order to fully integrate the fault information of voltage and current signals, these signals can be converted into 2D tensors similar to single-channel grayscale images. 2D-CNN has been verified its advantages in image classification tasks in References [28–30]. Therefore, the fault segment identification task can be completed by 2D-CNN. After the signal output from 2D-CNN passes through the flatten layer, a time series containing rich feature information can be obtained. These time series are used for precise fault location by a regressor such as 1D-CNN, LSTM, GRU or Bi-GRU. Although CNN has feature extraction ability inherently, the learning effect of the model can be improved by feature engineering in the case of a limited sample size. In Reference [15], empirical mode decomposition (EMD) was used for feature engineering,

which may have a modal aliasing phenomenon in the EMD decomposition process. In addition, the proposed method in Reference [15] is still strongly dependent on the sample size, and a large amount of memory could be occupied. Therefore, feature engineering and deep learning models need to be further studied for fault location.

The above analysis shows that the regressor needs to integrate the information of the classification results to achieve accurate fault location. Herein, a hybrid model of 2D-CNN and LSTM (CNN-LSTM) was adopted in this study. The main contributions of this work are as follows:

- (1) CNN-LSTM was used to solve many shortcomings of the single-ended traveling wave method, including high sampling frequency, difficulty to determine wave velocity and identify wave heads when an HIF occurs. It provides high precision and strong robustness to fault types, noise, sampling frequency, and different HVDC topologies in fault location.
- (2) VMD-TEO was used for feature engineering, which made the characteristics of the fault signals obvious. It reduced the dependence of deep learning on the number of samples to a certain extent, thereby improving the learning efficiency and accuracy of CNN-LSTM.
- (3) A comparison experiment of 1D-CNN and recurrent networks including LSTM, GRU and Bi-GRU as a regressor in the hybrid model explained the reason for choosing LSTM. Compared with feature engineering methods such as WT and HHT, VMD-TEO showed a better performance on the accuracy of fault location through CNN-LSTM.

The rest of the paper is organized as follows: Section 2 introduces the principle of the single-ended traveling wave method and points out the difficulties of its application. The process of feature engineering by VMD-TEO and identifying fault sections by 2D-CNN are introduced. Section 3 describes a fault location approach, and presents a hybrid model comprising CNN and LSTM. Section 4 discusses the simulation parameters, results, and analysis. Section 5 provides the conclusions.

2. Fault Location Based on Traveling Wave Theory

2.1. Feature Engineering and Acquisition of Samples

This study mainly investigated the fault location of hybrid transmission lines in a bipolar HVDC system, and its structure is shown in Figure 1. The transmission line on the DC side contains a mix of cables and overhead lines. Their connection point is denoted as J. The DC side close to the power supply and power receiving terminals are denoted as M and N, respectively.

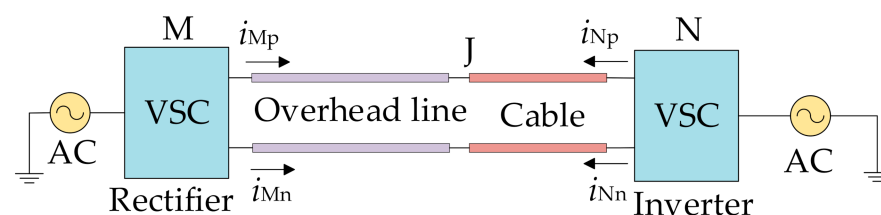


Figure 1. Hybrid two-segment voltage source converter–high voltage direct current (VSC-HVDC) system.

To identify the fault sections, 2D-CNN was considered to classify the characteristic quantities of the fault voltage and current signals at terminal M. Feature engineering is extremely important for identifying fault sections. VMD-TEO was mainly used for this task in this work. A large number of fault signals could be obtained as input samples for CNN considering the combination scenarios of different fault locations, fault types, and transition resistance. The process of obtaining one of these samples is described below.

Bipolar lines have mutual coupling problems, and their parameters have frequency conversion characteristics. Phase-mode analysis is necessary to simplify the calculation

process before feature extraction of fault signals. The specific process of phase-mode transformation is expressed as the following formula [31]:

$$\begin{bmatrix} i_{m0} \\ i_{m1} \end{bmatrix} = \frac{1}{\sqrt{2}} \begin{bmatrix} 1 & 1 \\ 1 & -1 \end{bmatrix} \cdot \begin{bmatrix} i_p \\ i_n \end{bmatrix} \quad (1)$$

where i_{m0} and i_{m1} are the current or voltage of the ground-mode and aerial-mode traveling wave after decoupling, respectively, and i_p and i_n are the fault current or voltage of the corresponding positive and negative electrodes, respectively.

The principle of VMD-TEO singularity detection was described in detail in References [13,14]. The authors compared this method with WT, HHT, and EMD to prove its excellent detection performance. Feature engineering is mainly through decomposing the fault voltage and current signals at terminal M into several intrinsic mode function (IMF) [32,33] components by VMD and analyzing the first IMF component (IMF1) to obtain Teager energy values (TEVs) by TEO.

To improve the classification effect of 2D-CNN, the TEVs of voltage and current need to be preprocessed using min-max normalization to make them at the interval [0,1], which can be expressed as follows:

$$x^* = \frac{x - x_{\min}}{x_{\max} - x_{\min}} \quad (2)$$

where x^* is the normalized value, and x_{\max} and x_{\min} are the maximum and minimum values in the sample data, respectively.

The specific HVDC simulation model and related parameter settings are described in detail in Section 4. The sampling frequency was selected to be 100 kHz to improve the accuracy of fault location using the traveling wave method. The time window is 40.96 ms, i.e., 4096 sampling points are found in each time window. Considering the influence of the measurement noise at terminal M, 1% reference signal noise is added to the fault voltage and current of the two poles. Phase-mode transformation is first conducted, and the TEVs of the voltage and current are then calculated and normalized. In this way, a matrix with a size of 2×4096 is obtained, which is a 2D-tensor as an input sample. Considering different fault distances, transition resistance, and fault type scenarios, many input samples can be obtained.

It is assumed that an NG fault occurs at a distance of 350 km from the M terminal, with the transition resistance of 0.03Ω , the failure time of 4 s, and the duration of 0.02 s. The aerial-mode component of the fault voltage and fault current after noise is added, and the TEVs before normalization is shown in Figure 2. VMD has a good filtering effect because fault signals in Figure 2c,d are much smoother than Figure 2a,b. The calculation of the TEVs based on IMF1 is shown in Figure 2e,f. They have much more high-frequency characteristic signals than Figure 2c,d. Therefore, more useful information of fault signals can be learned after VMD-TEO feature engineering. There is a slight difference in extreme value distribution in addition to the amplitude of TEVs of voltage and current between Figure 2e,f. The TEVs of voltage and current are constructed into 2D-tensor to complement each other with information. The work of classifying fault segments based on this characteristic information needs to be handed over to 2D-CNN for completion. The process of the above feature engineering is shown in Figure 3.

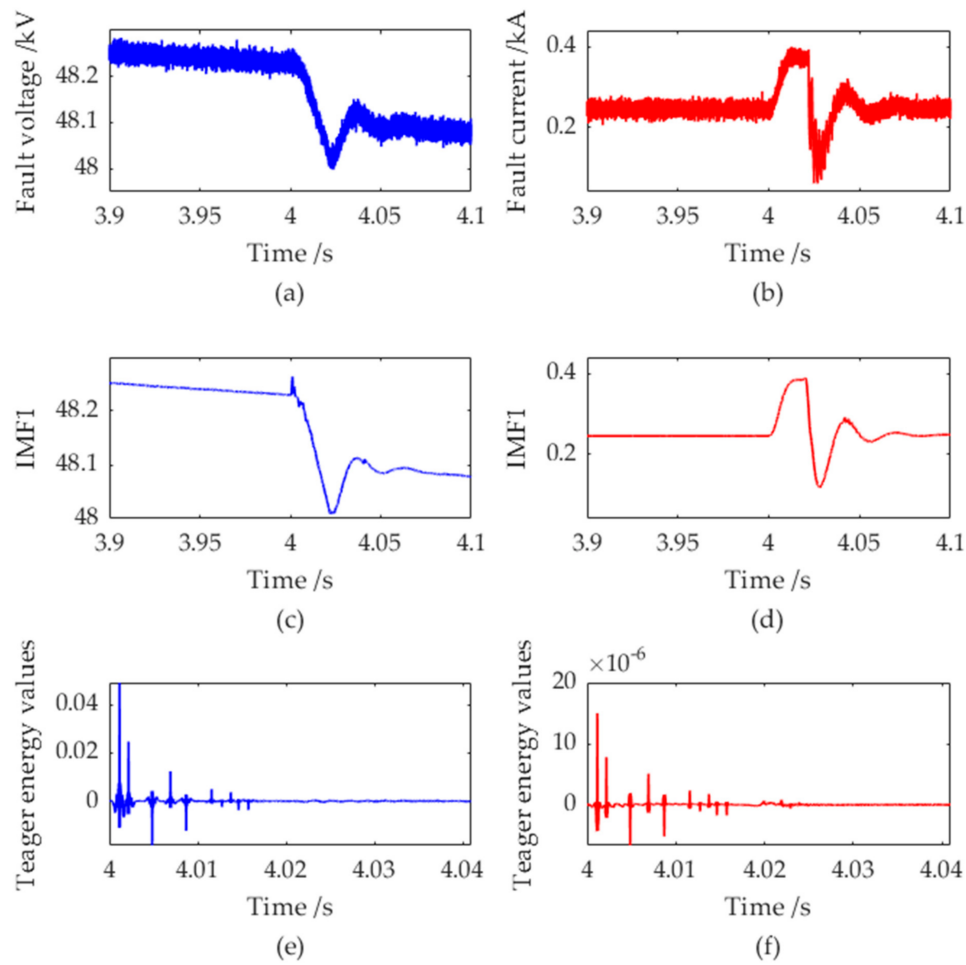


Figure 2. Feature engineering analysis results of negative ground (NG) fault occurring at 350 km; (a) fault voltage with noise, (b) fault current with noise, (c) IMF1 of fault voltage by variational mode decomposition (VMD), (d) IMF1 of fault current by VMD, (e) Teager energy values (TEVs) of the first intrinsic mode function (IMF1) in fault voltage, and (f) TEVs of IMF1 in fault current.

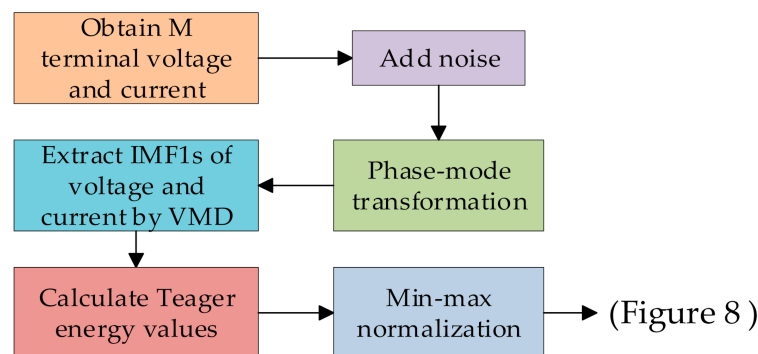


Figure 3. Process of feature engineering.

2.2. Fault Segment Identification Based on 2D-CNN

A deep 2D-CNN model was built, as shown in Figure 4. This model consists of 19 layers, including an input layer, six convolutional layers (C_1 – C_6), six pooling layers (S_1 – S_6), a flatten layer (R_1), two dense layers (F_1 , F_2), two dropout layers (D_1 , D_2), and a softmax layer (F_3). The parameter configuration of each layer in this model is listed in Table 1.

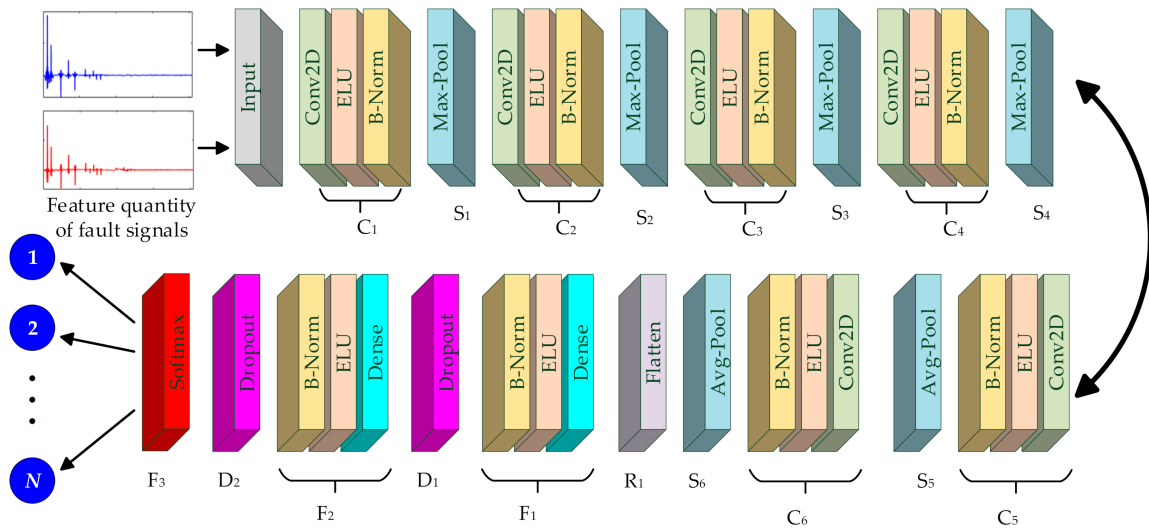


Figure 4. Deep 2D-CNN structural diagram for fault segment identification.

The convolution layer operation can be described as:

$$x_j^l = f(z_j^l) = f\left(\sum_{i \in M_j} w_{ij}^l * x_i^{l-1} + b_j^l\right) \quad (3)$$

where $*$ is the convolution operation, l is the l -th layer in the network, i is the i -th weight in the kernel, j is the j -th kernel, M denotes local feelings, w is the weight of synaptic connections, b is the bias coefficient, z is the result after the convolution operation, x_i is the input sample or the feature sample of the previous layer, x_j is the output feature sample, and f is the activation function to be selected.

The main chosen activation function of the proposed model is the exponential linear unit (ELU). Compared with the rectified linear unit function, ELU has a negative part. The linear part of ELU can alleviate the vanishing gradient problem, and the negative part can be robust to input changes or noise [34].

The pooling layer can compress and filter the feature samples outputted by the convolution layer, thereby reducing redundant information and network parameters and improving the performance and robustness of the network. The pooling layer operation can be described as:

$$x_j^l = f(\lambda_j^l * \text{down}(\lambda_j^{l-1}) + b_j^l) \quad (4)$$

where $\text{down}(\cdot)$ is the subsampling method to be selected, and λ is the weight of the pooling layer.

The fully connected layer can integrate the features of all neurons in the previous layer. The first fully connected layer, such as flatten layer (R_1) in Figure 4, has a tiling function that can tile neurons on multiple multidimensional feature samples into 1D vectors. The operation of the fully connected layer can be described as:

$$x_j^l = f(z) = f(\zeta_j^l x_j^{l-1} + b_j^l) \quad (5)$$

where ζ is the weight of the fully connected layer, and f is the ELU activation function.

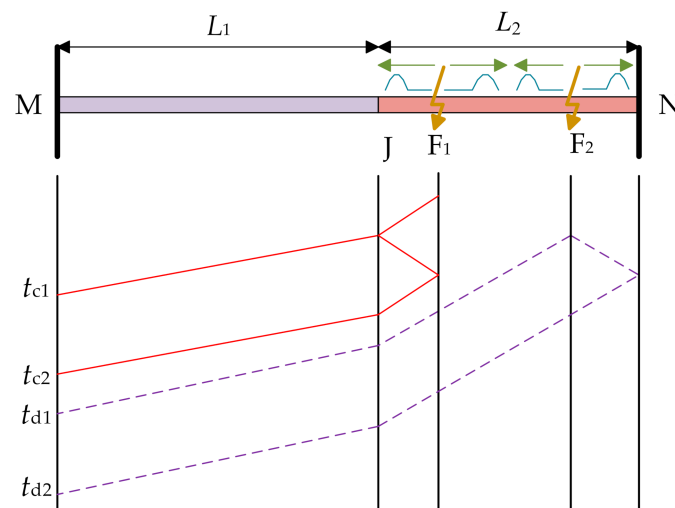
To prevent overfitting during the learning process, regularization is needed to reduce the generalization error of the model. Batch normalization can prevent gradient dispersion and explosion. The dropout layer can make neurons randomly deactivate with a certain probability, thereby compressing the number of neurons, improving the model learning speed, and effectively reducing overfitting. Here dropout layers (D_1 , D_2) are set as 0.3 and 0.2, respectively.

Table 1. Architecture of the proposed 2D-CNN model.

Layer Types	Kernel/Pool Size	Sub-Sampling Layer	Stride	Number of Kernels	Number of Neurons	Activation Function	Outputs
Input layer	-	-	-	-	-	-	$2 \times 4096 \times 1$
C ₁	2×2	-	1	16	-	ELU	$2 \times 4096 \times 16$
S ₁	2×2	Maximum	2	-	-	-	$1 \times 2048 \times 16$
C ₂	2×2	-	1	16	-	ELU	$1 \times 2048 \times 16$
S ₂	1×2	Maximum	2	-	-	-	$1 \times 1024 \times 16$
C ₃	2×2	-	1	32	-	ELU	$1 \times 1024 \times 32$
S ₃	1×2	Maximum	2	-	-	-	$1 \times 512 \times 32$
C ₄	2×2	-	1	32	-	ELU	$1 \times 512 \times 32$
S ₄	1×2	Maximum	2	-	-	-	$1 \times 256 \times 32$
C ₅	2×2	-	1	64	-	ELU	$1 \times 256 \times 64$
S ₅	1×2	Average	2	-	-	-	$1 \times 128 \times 64$
C ₆	2×2	-	1	64	-	ELU	$1 \times 128 \times 64$
S ₆	1×2	Average	2	-	-	-	$1 \times 64 \times 64$
R ₁	-	-	-	-	-	-	4096
F ₁	-	-	-	-	200	ELU	200
D ₁	-	-	-	-	-	-	200
F ₂	-	-	-	-	64	ELU	64
D ₂	-	-	-	-	-	-	64
F ₃	-	-	-	-	N	Softmax	N

2.3. Single-Ended Traveling Wave Method for Fault Location

The laws of refraction and reflection of traveling waves on actual HVDC transmission lines vary in different fault segments [7]. The reflected wave head identified on the rectifier side may come from the fault point, the connection point of the hybrid line, or even the bus on the inverter side [23]. Different calculation formulas are adopted in the single-ended traveling wave method when faults occur in different sections [7,23]. When the fault section is located in the first or second halves of the cable, the fault traveling wave propagation is depicted in Figure 5. The lengths of the overhead line and the cable are L_1 and L_2 , respectively. As reported in Reference [16], the wave velocity is a frequency-dependent variable. The traveling wave velocities on the overhead line and the cable are $v_1(\omega)$ and $v_2(\omega)$, respectively. Here ω is the frequency when the traveling wave component reaches the rectifier side. Δt is the time difference between the second traveling wave head and the first traveling wave head identified at the M terminal. The distance from the fault point to the M terminal is x , which is the fault location result.

**Figure 5.** Fault traveling wave propagation on different sections.

As shown in Figure 5, $L_1 < x < L_1 + L_2/2$ when the fault occurs at F_1 , and $L_1 + L_2/2 < x < L_1 + L_2$ when the fault occurs at F_2 . When the fault point is at F_1 , the path of the traveling wave is F_1 -J- F_1 -J-M, i.e., the second traveling wave head recognized by the M terminal is the reflected wave from the fault point. The fault distance can be calculated using the following formula:

$$x = L_1 + \frac{v_2(\omega)\Delta t}{2} = L_1 + \frac{v_2(\omega)(t_{c2} - t_{c1})}{2} \quad (6)$$

When the fault point is at F_2 , the path of the traveling wave is F_2 -N- F_2 -J-M, i.e., the second traveling wave head recognized by the M terminal is the reflected wave from the opposite bus N. The fault distance can be calculated by the following formula:

$$x = L_1 + L_2 - \frac{1}{2}v_2(\omega)\Delta t = L_1 + L_2 - \frac{1}{2}v_2(\omega)(t_{d2} - t_{d1}) \quad (7)$$

There is a complicated nonlinear relationship of the fault distance, the time of the traveling wave reaching the rectifier side and the traveling wave velocity.

3. Fault Location Based on CNN-LSTM

The information on the time of traveling wave reaching the rectifier side and wave velocity can be obtained through combining the fault signal after feature engineering with the corresponding fault distance. A nonlinear relationship is found between these feature quantities and fault distance. These feature quantities have time correlation since it can be regarded as time series. LSTM can be used for the regression prediction of fault distances. The complete fault location process of CNN-LSTM is shown in Figure 6. The fault voltage and current are obtained at the M terminal. High-frequency components (TEVs) of the fault traveling wave are extracted by phase-mode transformation and VMD-TEO. Then TEVs are constructed into a 2D-tensor as an input of 2D-CNN. Finally, the fault location is performed through the trained LSTM model.

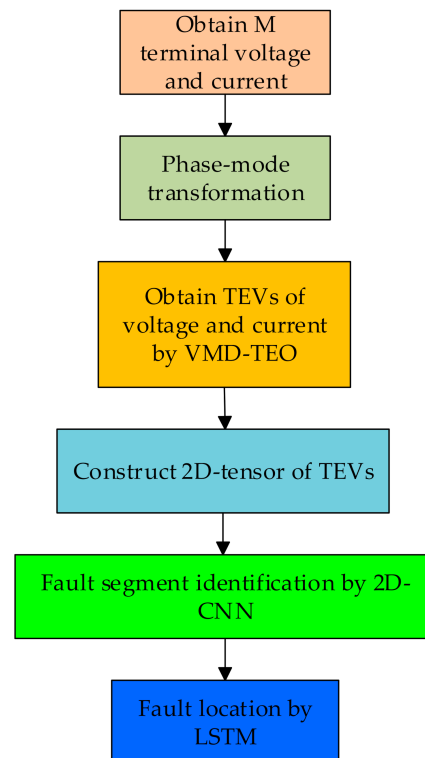


Figure 6. Fault location based on CNN-long short-term memory (LSTM).

3.1. Theoretical Background of LSTM

An LSTM network is an improved temporal recurrent neural network. The introduction of a forgetting gate solves the problem of gradient disappearance during training, enabling LSTM to learn the long-term and short-term dependence information of time series [18,30]. Its network basic unit is shown in Figure 7.

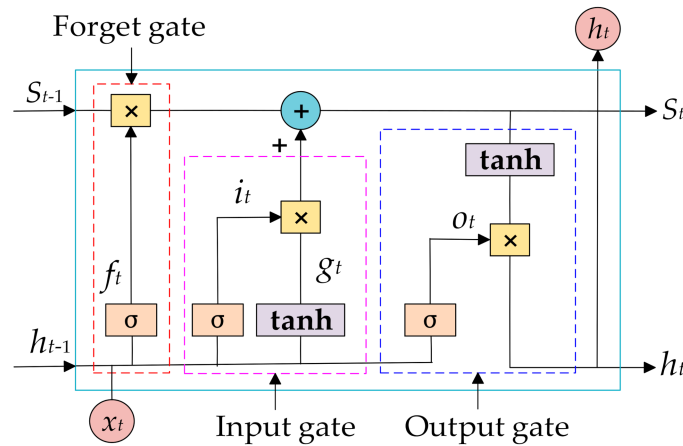


Figure 7. Basic unit of LSTM network.

The basic unit of LSTM contains forget, input, and output gates. Input x_t in the forget gate, state memory unit S_{t-1} , and intermediate output h_{t-1} together determine the forgotten part of the state memory unit. x_t in the input gate is determined by the sigmoid and tanh functions to jointly determine the vector retained in the state memory unit. Intermediate output h_t is jointly determined by the updated S_t and o_t . The calculation formulas in these processes are expressed as follows:

$$f_t = \sigma(W_{fx}x_t + W_{fh}h_{t-1} + b_f) \quad (8)$$

$$i_t = \sigma(W_{ix}x_t + W_{ih}h_{t-1} + b_i) \quad (9)$$

$$g_t = \varphi(W_{gx}x_t + W_{gh}h_{t-1} + b_g) \quad (10)$$

$$o_t = \sigma(W_{ox}x_t + W_{oh}h_{t-1} + b_o) \quad (11)$$

$$S_t = g_t \odot i_t + S_{t-1} \odot f_t \quad (12)$$

$$h_t = \varphi(S_t) \odot o_t \quad (13)$$

where f_t , i_t , g_t , o_t , h_t , and S_t are the states of the forget gate, input gate, input node, output gate, intermediate output, and state unit, respectively, W_{fx} , W_{fh} , W_{ix} , W_{ih} , W_{gx} , W_{gh} , W_{ox} , and W_{oh} are the matrix weights of the corresponding gate multiplied by input x_t and intermediate output h_{t-1} , b_f , b_i , b_g , and b_o are the bias terms of the corresponding gate. \odot is the bitwise multiplication of the elements in the vector. σ is the sigmoid function, and φ is the tanh function.

3.2. CNN-LSTM Hybrid Model for Fault Location

A CNN-LSTM hybrid model showed in Figure 8 is built based on the previous 2D-CNN structure. The model 2D-CNN in the left half as a classifier completes the task of identifying fault segments, and the model LSTM in the right half as a regressor completes the task of precise fault location. The fault segment with the highest probability output from the softmax function is selected as the current fault segment. The feature information output by the flatten layer (R_1) in 2D-CNN and the probability information of the fault segment are calculated by the regressor. The experimental results demonstrate that six LSTM layers should be used in the CNN-LSTM network, and each LSTM layer contains 64 neurons. The

dense layer (F_4) uses a neuron. The loss function is mean squared error, and the optimizer is Adam. The proposed hybrid network model can intelligently integrate information from different fault sections and corresponding fault distances, and continuously optimize and update network parameters to make it close to ideal.

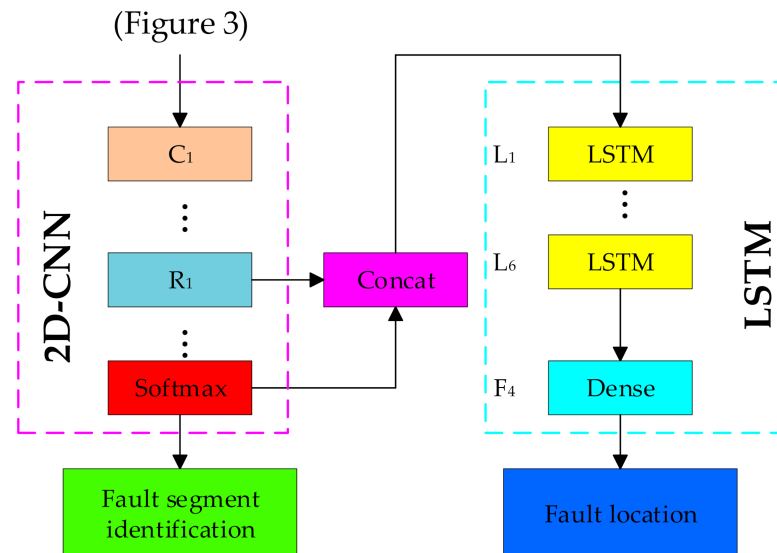


Figure 8. CNN-LSTM hybrid model.

With the development of modern data acquisition technology and deep learning technology, the proposed method is feasible for engineering applications. A high-precision and adjustable sampling frequency transient recorder is installed on the M terminal to obtain a large number of fault sample data. The operation of the proposed method can be accelerated by parallelizing on graphical processing units or tensor processing units. After the proposed model is trained, it can be used repeatedly for fault location, and the speed is calculated in milliseconds. Circuit breakers in HVDC systems, which is a key element to interrupt and clear the faults [35]. The fault location speed of the proposed method can meet the operating time requirements of an actual circuit breaker. Feature engineering is performed in MATLAB 2019a. The model training and testing are carried out on the Python3.7 Keras framework.

4. Simulation Results and Analysis

4.1. Simulation Model and Related Parameters

The voltage source converter (VSC)-HVDC transmission system with mixed lines in Figure 1 is constructed on the power system simulation software PSCAD/EMTDC. The model proposed in Reference [14] was used in this study. Its structure and related parameter settings remained constant. In this paper, a bipolar DC transmission line power and a current double closed-loop proportional–integral (PI) control were adopted. The VSC overall control system structure is shown in Figure 9a comprising the inner loop current controller, outer loop power regulator, phase lock synchronization, trigger pulse generation, and other components, in which the inner loop current controller is used to directly control the AC side current waveform and the phase of the converter is applied to rapidly track the reference current. The outer loop power control is based on the control objectives of the system, i.e., DC voltage, active power, fixed frequency, reactive power, constant AC voltage, and other control objectives. The outer loop control mode of the M-side keeps constant active power control and constant reactive power control, whereas the outer loop control mode of the N-side is constant DC voltage and constant reactive power control. The inner loop controllers of the M-side and N-side are identical, and their controller structure is demonstrated in Figure 9b.

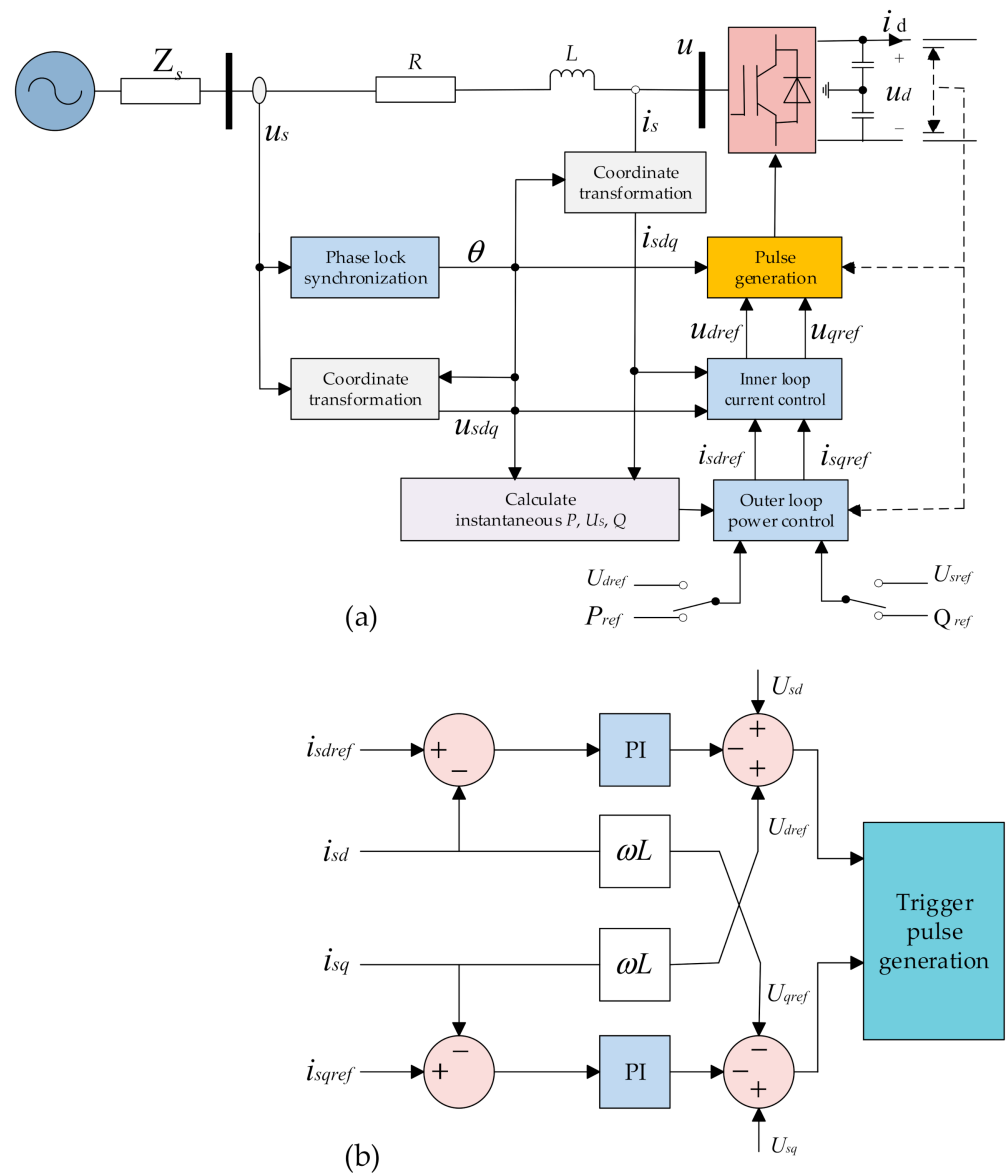


Figure 9. Voltage source converter (VSC) control system structure; (a) overall controller structure and (b) inner loop controller structure.

The M-side system was modeled by a three-phase voltage source with the following main parameters; the line voltage of 110 kV, system impedance of 1.7 Ω , transformer Yn/ Δ link capacity of 25 MVA, winding voltage of 110 kV/25 kV, leakage resistance of 0.2 pu, phase reactor of 0.053 H, and equivalent resistance of 0.8 Ω . The N-side system was simulated as an infinite system by a three-phase voltage source with the following main parameters; the system impedance of 0 Ω , line voltage of 110 kV, transformer Yn/ Δ link, capacity of 20 MVA, winding voltage of 110 kV/25 kV, leakage resistance of 0.1 pu, phase reactor of 0.053 H, and equivalent resistance 0.6 Ω . Modeling cables and overhead lines using the frequency dependent (phase) approach are shown in Figure 10. The resistance, sheath resistivity, and armor resistivity of the cable are 1.72×10^{-8} , 2.2×10^{-7} , and 1.8×10^{-7} $\Omega \cdot m$, respectively. The relative dielectric constant of the insulator is 2.5 with length of 200 km. The resistance, GMR, and length of the overhead wire are 0.03206 Ω/km , 0.0122834 m, and 300 km, respectively.

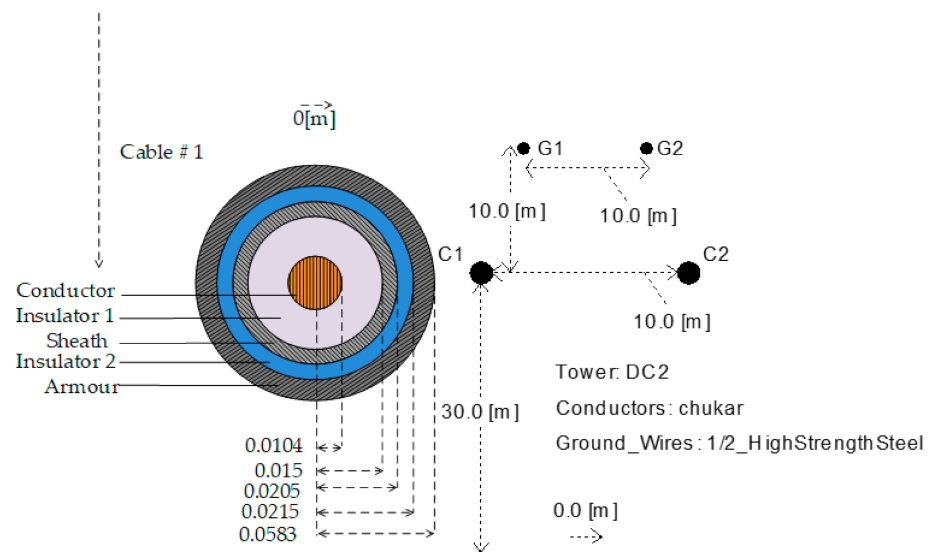


Figure 10. Parameters of cables and overhead lines.

4.2. Experimental Result of Traveling Wave Method

The fault resistance value used to distinguish HIF and LIF is related to specific HVDC system parameters. This research is mainly based on the change of the fault current. An assumption is that a positive ground (PG) fault occurs at a distance of 50, 150, 300 and 400 km from the M terminal. When the transition resistance R_f changes, the aerial-mode component of the fault current is shown in Figure 11. When R_f is less than 100 Ω , the fault current amplitude is larger and its variety is more obvious than that when R_f is between 800 and 1200 Ω . Through this analysis, it can be seen that the fault resistance of LIF and HIF ([0, 100 Ω] and [800 Ω , 1200 Ω], respectively) is one of the reasonable circumstances.

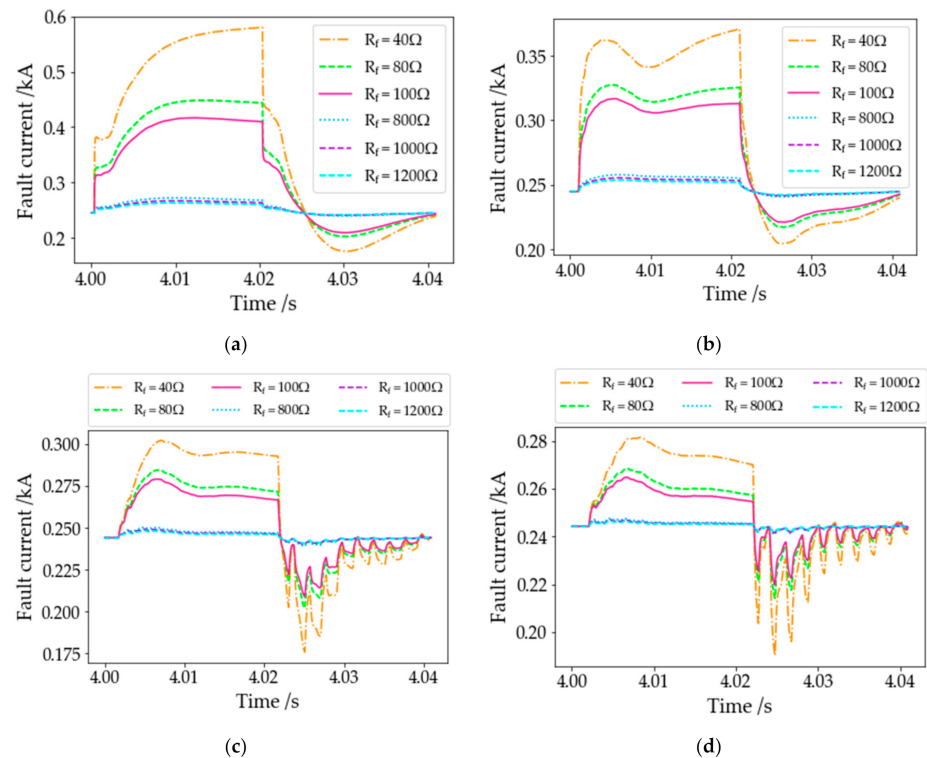


Figure 11. Fault current at M terminal when the transition resistance R_f changes; (a) PG fault at 50 km, (b) PG fault at 150 km, (c) PG fault at 300 km, and (d) PG fault at 400 km.

As depicted in Reference [7], the hybrid line was divided into four fault segments, and SVM was used to identify these sections. In this work, 2D-CNN was used to achieve this aim. A large number of CNN input samples can be obtained through different fault scenarios. The sampling frequency and time window are 100 kHz and 40.96 ms, respectively. A total of 4096 sampling points is found in each time window. Three fault conditions include PG, NG, and short between positive and negative (PN). The maximum transition resistance is 100 Ω with LIF considered. The performance of the proposed method is evaluated for various fault scenarios under different system conditions. The simulations are conducted with the following values or types:

- (1) The change step size of the fault distance is taken as 1 km.
- (2) Transition resistance $R_f = 0.0001\%$, 1%, 2%, 3% ... 100% of the maximum transition resistance.
- (3) Fault types include PG, NG, and PN.

A total of 151,197 different cases were simulated, and 1% reference signal noise was considered. After performing feature engineering by VMD-TEO on all simulation results, 151,197 input samples can be obtained as input samples for CNN. Due to the large number of samples, only samples with fault points located at 50, 150, 300 and 400 km are displayed in Figure 12. There are 101 samples in each of the three fault scenarios corresponding to each fault distance. In different fault sections, changes of the voltage and current are different as shown in Figure 12a–d,i–l. After the fault signals are processed by VMD, the high frequency components, which are IMFs, of the fault traveling wave can be obtained as shown in Figure 12e–h. Yet, the characteristics of these components are not obvious. If they are directly used in deep learning for fault segment identification and fault location, the number of training samples and the complexity of the neural network will greatly increase. However, after VMD-TEO feature engineering is performed on the fault signals, as shown in Figure 12m–p, the information of these high-frequency components will become clearer. Therefore, this feature engineering is conducive to the learning of the CNN-LSTM network. The extreme point positions of the high-frequency components (TEVs) are related to the fault distances, and are less affected by the fault types. Simultaneously, the amplitude of these components and the polarity of the extreme values varied with the fault distances. TEVs of IMFs are feasible as input to the CNN-LSTM model.

Randomly take 80% of the total sample as training data and the remaining samples as test data. One-hot coding is performed for the four fault sections, i.e., the first and second halves of the overhead line and cable are encoded as [1,0,0,0], [0,1,0,0], [0,0,1,0], and [0,0,0,1].

When LIF occurs, the test results are represented by a normalized confusion matrix, as shown in Figure 13a. The recognition effect of the four fault sections is excellent with an accuracy rate over 99.5% in Figure 13a. Under consideration of HIF, the value range of fault resistance is [800 Ω , 1200 Ω]. In this interval, the change step of fault resistance is 4 Ω . The other failure scenario settings are the same as above, and a total of 151,197 different cases can also be obtained. The normalized confusion matrix of the test results in this case is shown in Figure 13b. The recognition effect of the four fault sections is extremely poor, the lowest and fault recognition rates are 46.1% and 57.3%, respectively. The classification method of the four fault sections can only be used in the case of LIF and is not applicable to the case of HIF.

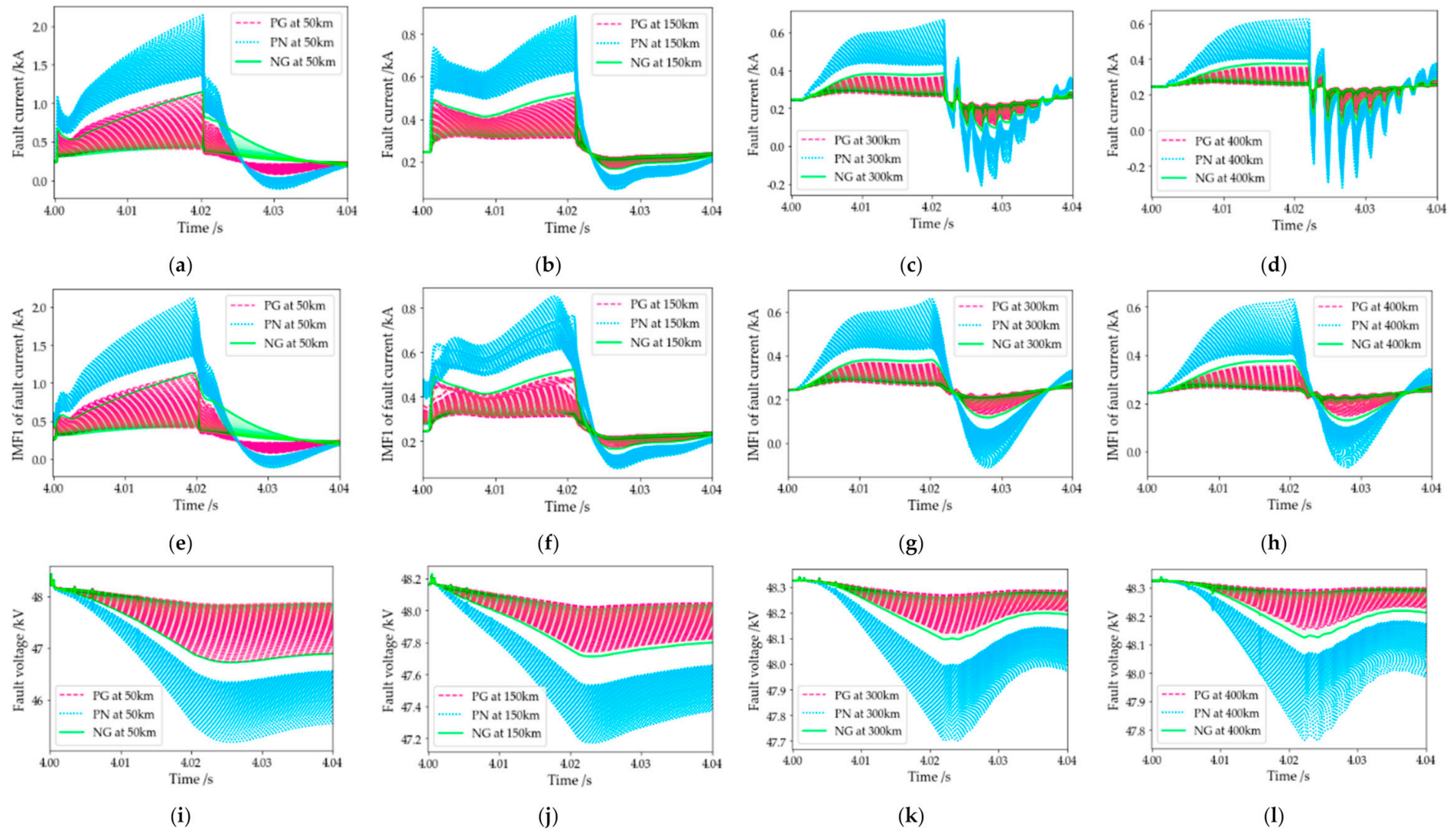


Figure 12. Cont.

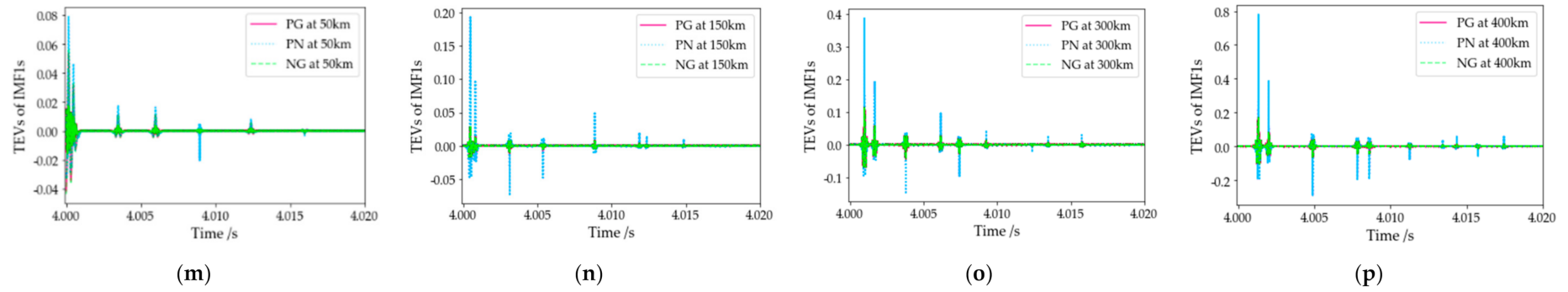


Figure 12. Partial samples when faults occur at 50, 150, 300 and 400 km. (a–d) Fault current without noise; (e–h) IMF1 of fault current by VMD; (i–l) fault voltage without noise; (m–p) TEVs of IMF1s in fault voltage.

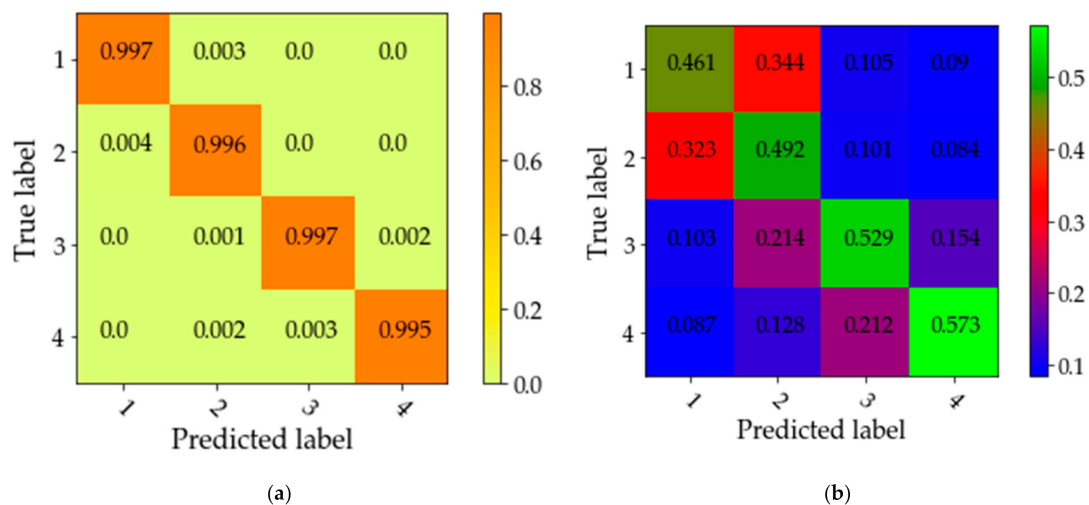


Figure 13. Normalized confusion matrix of classification effect; (a) low impedance fault (LIF) and (b) high impedance fault (HIF).

Assuming that PN LIF occurs at a distance of 450 km from the M terminal, the transition resistance is 10Ω , the time of failure is 4 s, the duration is 0.02 s, and the fault section can be correctly identified. The fault current signal at the M terminal and the result of the singularity detection using the VMD-TEO are recorded in Figure 14. The IMF1 obtained by VMD can reflect the essential characteristics of the fault signal. After calculating the TEV of IMF1, evident extreme points are obtained. The positions of these extreme points can reflect the positions of singular points of the signal. In accordance with the previous analysis, the first two extreme points are the traveling wave initial wave head and the opposite wave bus head, respectively. The fault distance can be calculated using Formula (7), where $t_{d1} = 4.00175$ s, $t_{d2} = 4.00233$ s. According to the theoretical analysis [7,14], it is assumed that the parameters of the aerial-mode component do not change much, and the influence of frequency on the traveling wave velocity is ignored. Since the HVDC model and parameters in this study are exactly the same as that described in Reference [14], the fixed aerial-mode traveling wave velocities in Reference [14] are used for calculation, where $v_1 = 293,997.1102$ km/s, $v_2 = 196,333.3333$ km/s. The theoretical value of fault distance is 443.063 km, the error distance of fault distance is 6.937 km, and the error percentage is 1.54%. This error does not meet the actual engineering requirements. The possible reason of the error is that fixed traveling wave velocities are adopted while ignoring their frequency variation characteristics.

4.3. Experimental Result of CNN-LSTM

Several shortcomings are found in the previous fault location analysis of the traveling wave method. The connection points of the fault sections are not considered. The effect of identifying HIL is extremely poor. Many overlapping fault sections are considered to solve these problems.

The length of the mixed line and the overlap of the fault sections are considered as the length of the sample (L_s) and its offset (Δs), respectively. When Δs is large, the number of categories (N) of the fault sections is small. When N is small, the recognition rate for HIF is low. When N is large, the data amount and learning effect of CNN-LSTM are affected. Therefore, the selection of appropriate Δs is very important for accurate fault location.

The length of the mixed line is 500 km, and the interval of L_s is $[0, 500]$. When $\Delta s = 100$, $N = 4$, the fault sections are $[0, 200]$, $[100, 300]$, $[200, 400]$, and $[300, 500]$. When $\Delta s = 50$, $N = 9$, the fault sections are $[0, 100]$, $[50, 150]$, \dots , and $[400, 500]$. When $\Delta s = 25$, $N = 19$, the fault sections are $[0, 50]$, $[25, 75]$, \dots , and $[450, 500]$. Δs is changed, and the classification

experiments of HIF and LIF are performed again. With the change in Δs ($\Delta s = 2, 5, 10, 20, 25$, and 100), the accuracy percentage of the 2D-CNN classifier is shown in Figure 15. The width of the ribbon in Figure 15 reflects the accuracy range of each fault segment identification, where the edges of the ribbon reflect the maximum and minimum accuracy, and the solid line reflects the average accuracy. When $\Delta s = 25$, i.e., $N = 19$, the classification effect of HIF and LIF is best with accuracies of 99.98% and 99.99%, respectively.

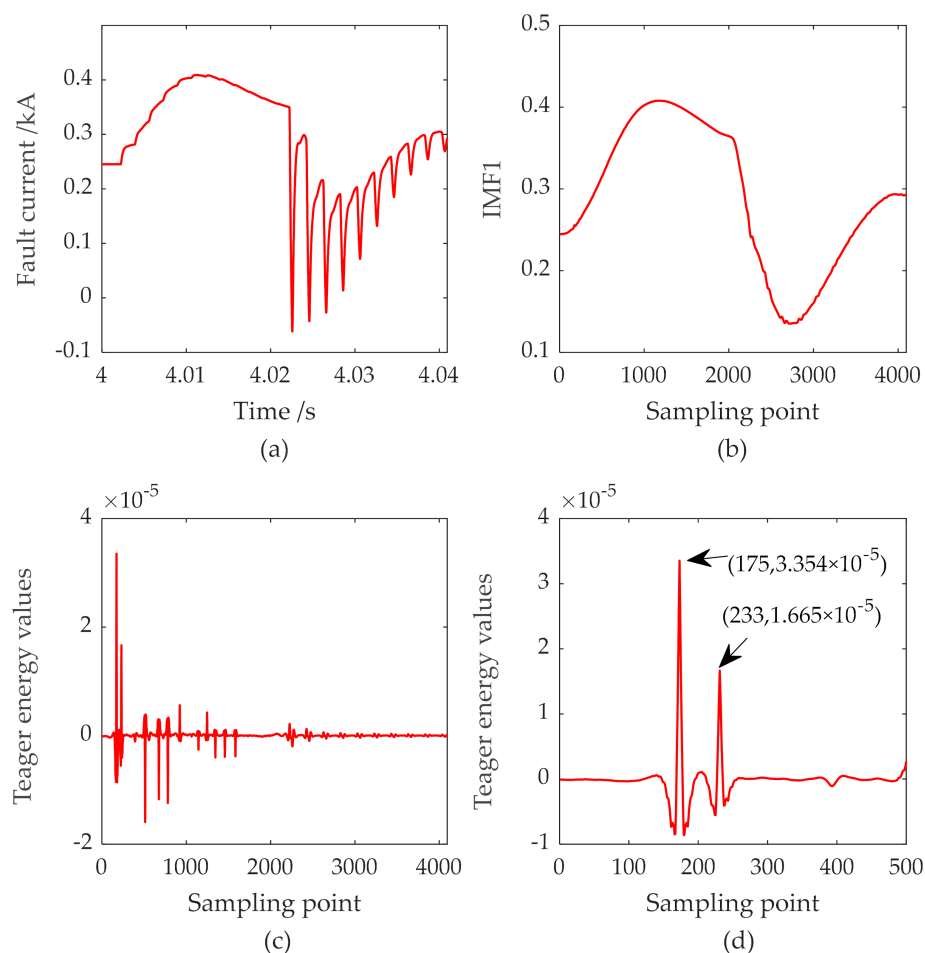


Figure 14. Experimental results of signal extraction and singularity detection for a PN fault at 450 km; (a) fault current at terminal M, (b) IMF1 obtained from VMD, (c) TEV of IMF1 with a time window of 40.96 ms, and (d) TEV of IMF1 with a time window of 5 ms.

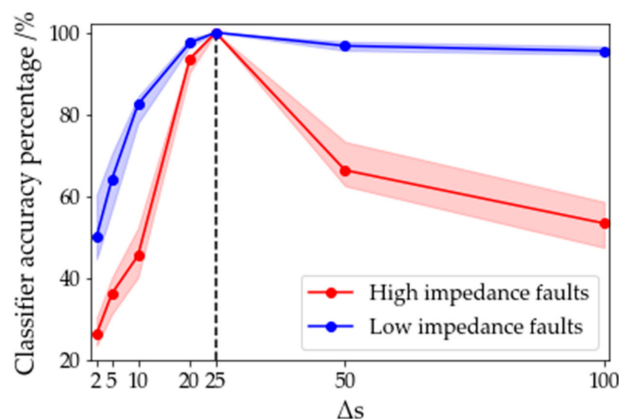


Figure 15. Test results when the number of categories changes.

The number of 2D-CNN layers can affect the classification effect of CNN-LSTM. Take the number of CNN layers as 4, 5, ..., 8 and $N = 19$ for experimental tests, and the results are shown in Figure 16, which is similar to Figure 15. When the number of 2D-CNN layers changes, the accuracy range of the classification in 19 fault sections includes the maximum, minimum, and average values. Properly increasing the number of 2D-CNN layers can improve the classification ability of the model. However, the accuracy of training decreases when the number of 2D-CNN layers exceeds six layers, indicating that the model is overlearning. When the number of 2D-CNN layers is 6, the accuracy of the classifier in the 19 fault sections is close to 100%, and the variation range is the smallest. Therefore, the 6-layer 2D-CNN model is reasonable as a classifier.

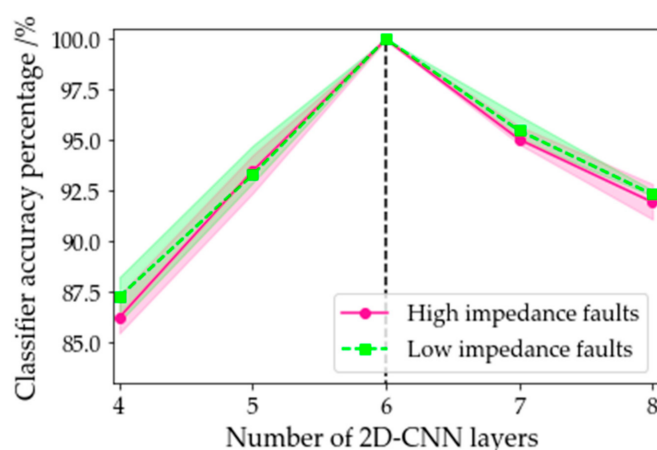


Figure 16. Test results when the number of 2D-CNN layers changes.

The influence of the number of LSTM layers on the regression effect of CNN-LSTM is also considered. Take the number of LSTM layers as 4, 5, ..., 8 and $N = 19$ for experimental tests, and the results are shown in Figure 17, which is similar to Figures 15 and 16. When the number of LSTM layers changes, the accuracy range of the regression prediction in each fault section includes the maximum, minimum, and average. The accuracy calculation sets a fault distance tolerance of $\pm 0.5\%$, thereby meeting the actual engineering requirements. The predicted values of multiple samples for each fault distance are averaged. The predicted value is recorded as accurate when the average is within the fault distance tolerance. When the number of LSTM layers is more than or less than six, the accuracy of the regressor is not as good as that of the six-layer LSTM. The predicted fault distances are highly accurate at each fault section.

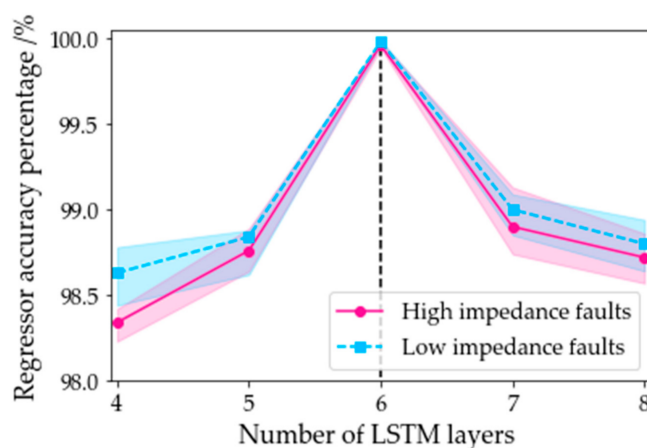


Figure 17. Test results when the number of LSTM layers changes.

The CNN-LSTM network with six LSTM layers was chosen for the test. The 500 sets of data with a fault distance of 12, 50, ..., and 450 km are randomly taken for experiments. Regression is used to predict the fault distance by CNN-LSTM and calculate the error. The experimental results of LIF and HIF are shown in Figure 18a,b, respectively. The color of the circle in the scatter plot reflects the value of fault resistance ($[0.01 \Omega, 100 \Omega]$, $[800 \Omega, 1200 \Omega]$), and the size of the circle reflects the fault types (PG, NG, PN). The vertical axis of the scatter plot is the fault distance error without considering the tolerance, i.e., the difference between the actual fault distance and its predicted value. The fault error values of LIF and HIF are approximately concentrated in the range of -0.4 to 0.4 km. The proposed method has small fault location error, and is less affected by fault resistances and fault types.

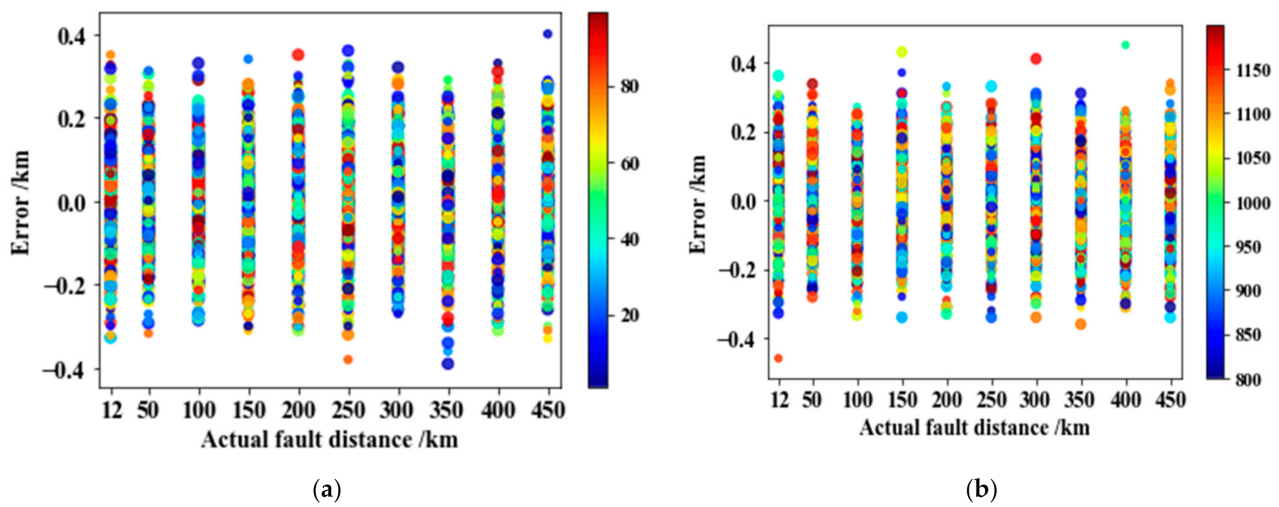


Figure 18. Test results of CNN-LSTM with six LSTM layers; (a) LIF and (b) HIF.

4.4. Influence of Sampling Frequency

The traveling wave method requires the measurement device to use a high sampling frequency, which is disadvantageous for practical engineering applications. To illustrate the effect of sampling frequency on the experimental results of CNN-LSTM, the sampling frequencies are taken as 100, 50, 20, 10, and 2 kHz. Regressive prediction is performed on 1000 groups of data with fault distances of 50, 150, 250, 350, and 450 km. The accuracy percentage of the fault location is obtained as follows:

$$acc\% = \left(1 - \frac{\left| y_{act} - \frac{1}{N_1 + N_2} \sum_{i=1}^{N_1+N_2} y_{pred}(i) \right|}{y_{act}} \right) \times 100\% \quad (14)$$

where y_{act} is the actual fault distance, y_{pred} is the predicted fault distance, N_1 and N_2 are the number of test samples for HIF and LIF, respectively, and $N_1 = N_2 = 500$.

The accuracy of fault location at different sampling frequencies is shown in Figure 19. When sampling frequency is between 20 and 100 kHz, the change in the accuracy of CNN-LSTM fault prediction is relatively stable. Therefore, the method requires lower sampling frequency than the traveling wave method.

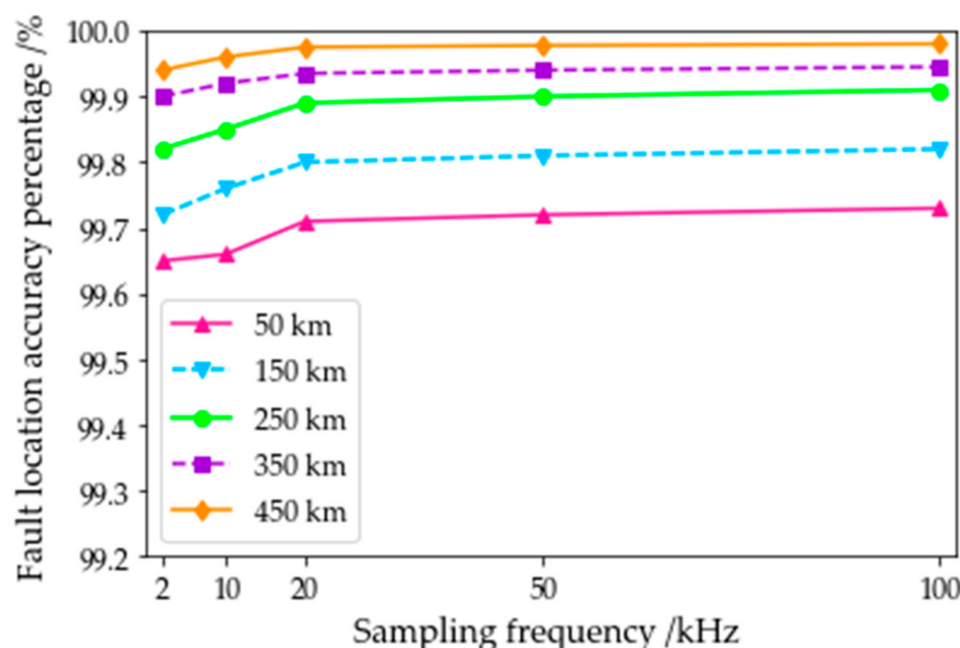


Figure 19. Test results at different sampling frequencies.

4.5. Influence of Noise

In the previous experimental analysis, the influence of measurement noise at the M terminal is considered, and 1% reference signal noise is added. Considering the effect of load changes during the actual operation of the HVDC system, 2% and 5% reference signal noises are added to the voltage and current signals at the M terminal. Similar to the process of analyzing the effect of sampling frequency on the accuracy of fault location, 1%, 2%, and 5% reference signal noises are added for fault prediction, and the sampling frequency is 50 kHz. The accuracy of fault location testing at different noise levels is shown in Figure 20. The effect of fault location is slightly affected by different levels of noise environment. The roles of VMD and CNN make the CNN-LSTM fault location method robust to noise.

4.6. Comparison of Other Methods

This study reasonably reduces the sampling frequency from 100 to 50 kHz to test HIF. In order to achieve a fair comparative test, the following methods adopt the same training and testing samples. Different feature engineering methods such as WT, HHT and VMD-TEO in this study are considered for experimental comparison. The experimental results are displayed in Table 2. The results by CNN-LSTM in the table are the average of 500 sets of test data. Since the data in the table are average values, it may happen that the test results cannot meet the allowable error range of actual engineering applications. Different feature engineering methods have a great influence on the accuracy of fault location, which can be seen in Table 2. It is verified here that the VMD-TEO method mentioned in our previous work [14] is superior to WT and HHT in terms of singularity recognition and robustness. The error in WT may be caused by the difficulty in using WT to select the basic functions and decomposition scales, and the error source of HHT may be a modal aliasing phenomenon in the EMD decomposition process.

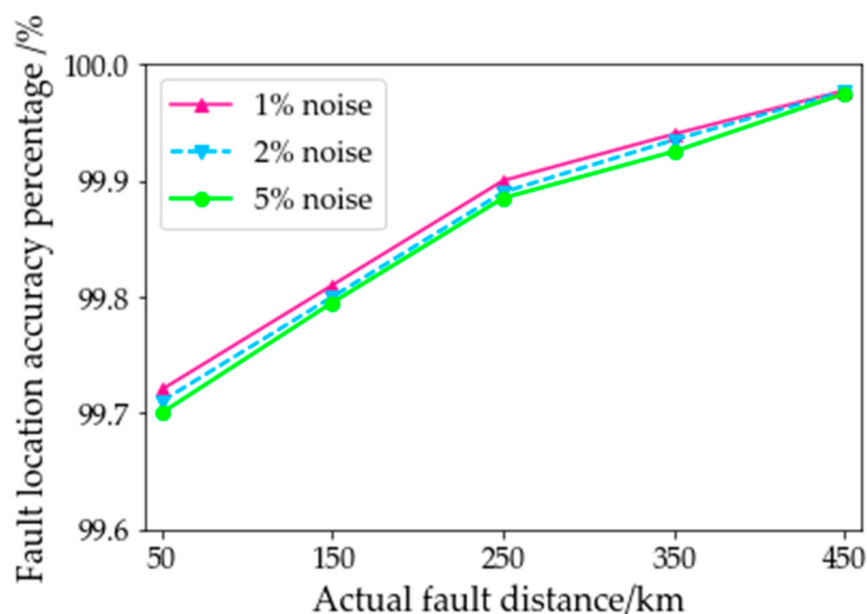


Figure 20. Testing results at different levels of noise.

Table 2. Comparison of feature engineering methods.

Fault Distance	WT		HHT		VMD-TEO	
	Distance	Error	Distance	Error	Distance	Error
(km)	(km)	(km)	(km)	(km)	(km)	(km)
50	53.797	3.797	53.386	2.386	50.137	0.137
100	103.827	3.827	95.564	4.436	99.773	0.227
150	153.624	3.624	153.518	3.518	150.265	0.265
200	196.671	3.329	204.447	4.447	200.272	0.272
250	254.227	4.227	244.596	5.404	250.257	0.257
300	305.106	5.106	304.234	4.234	300.251	0.251
400	404.534	4.534	396.522	3.478	400.197	0.197
450	446.575	3.425	455.416	5.416	450.234	0.234

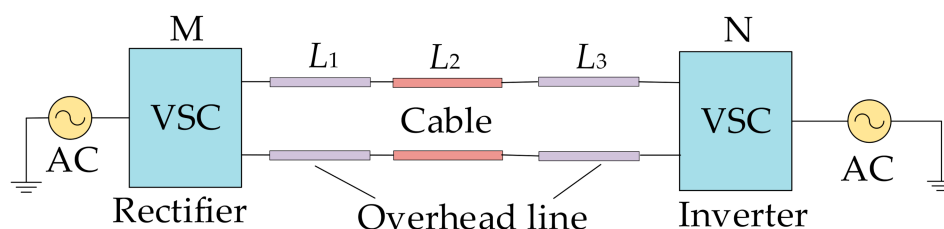
In order to facilitate the comparison of experiments, the 2D-CNN classifier structure of the left half of the proposed model remains unchanged. Other regression algorithms such as 1D-CNN, GRU, and Bi-GRU are used to replace the regressor in the right half of the proposed hybrid model. The experimental results by different regression methods are listed in Table 3. The comparison of the test effects of these three deep learning methods shows that the effect of LSTM in the regressor is significantly better than that of 1D-CNN, GRU, and Bi-GRU. The average error interval of CNN-LSTM, 1D-CNN, GRU and Bi-GRU are in [0.137, 0.265 km], [4.104, 5.213 km], [1.104, 1.333 km], and [1.821, 2.721 km], respectively. The fluctuation range of the error value of CNN-LSTM fault location is within the range of error tolerance value of actual engineering application. 1D-CNN has the worst experimental accuracy because its ability to learn the time correlation of fault signals is not as good as GRU, Bi-GRU and LSTM. GRU is a simplified model of the LSTM structure, which reduces the amount of calculation. However, reducing the model parameters may not guarantee that the regression effect is better than LSTM. Bi-GRU is that GRU learns the time series from the forward and reverse directions. The reason that the experimental accuracy of Bi-GRU is not as good as that of GRU and LSTM is that all regression prediction capabilities must come from the forward learning of the Bi-GRU network, and the reverse learning performs poorly on this task.

Table 3. Comparison of different regression algorithms.

Fault Distance (km)	1D-CNN		GRU		Bi-GRU		LSTM	
	Distance (km)	Error (km)	Distance (km)	Error (km)	Distance (km)	Error (km)	Distance (km)	Error (km)
50	54.186	4.186	51.186	1.186	51.919	1.919	50.137	0.137
100	104.333	4.333	101.333	1.333	98.179	1.821	99.773	0.227
150	154.221	4.221	151.221	1.221	151.978	1.978	150.265	0.265
200	195.896	4.104	198.896	1.104	202.149	2.149	200.272	0.272
250	254.131	4.131	251.131	1.131	252.721	2.721	250.257	0.257
300	305.213	5.213	301.213	1.213	302.497	2.497	300.251	0.251
400	404.238	4.238	401.238	1.238	397.768	2.232	400.197	0.197
450	445.879	4.121	448.879	1.121	452.011	2.011	450.234	0.234

4.7. Other HVDC Model

In order to verify the feasibility of the proposed method in the other HVDC model, the topology in Figure 1 is changed to the form in Figure 21. Here L_1 and L_3 are overhead lines with a length of 150 km, and L_2 is a cable with a length of 150 km. The CNN-LSTM model is retrained according to the previous program, and 10 samples are randomly selected for testing, as shown in Table 4. The error interval of the proposed method is in [0.249, 0.379 km]. This error range also meets engineering needs. By the analysis of Table 4, it can be concluded that this fault location method has higher accuracy when considering different HVDC topologies, and is also rarely affected by fault types and fault resistance.

**Figure 21.** Hybrid three-segment VSC-HVDC system.**Table 4.** Experimental results on hybrid three-segment system.

Fault Location (km)	Fault Type	Fault Resistance (Ω)	Distance (km)	Error (km)
40	PG	900	39.739	0.261
80	NG	75	80.379	0.379
120	PN	1100	119.668	0.332
150	PN	65	149.618	0.382
180	NG	29	180.317	0.317
250	PG	840	249.749	0.251
310	NG	920	310.346	0.346
375	PN	1020	374.688	0.312
400	PG	1120	399.627	0.373
440	NG	54	440.249	0.249

5. Conclusions

A deep CNN-LSTM method was proposed to locate the fault in HVDC systems with mixed cables and overhead lines. In the case of LIF and HIF, this method has high fault location accuracy with the effects of fault types, noise, sampling frequency, and different HVDC topologies in consideration.

VMD-TEO is used in feature engineering to improve the learning effect of the model. Experimental results prove that this method is superior to WT and HHT in feature extraction. This single-ended intelligent method transforms the problem of this research into two

tasks: fault section identification by a 2D-CNN classifier and fault precise location by an LSTM regressor. Simultaneously, the regressor integrates the fault section information in the classifier, and finally completes the fault location task. Other deep learning methods such as 1D-CNN, GRU and Bi-GRU replace LSTM in the regressor as an experimental comparison. Experimental results show that the fault location accuracy of LSTM is better than other methods.

Regarding the choice of the deep learning algorithm, it needs to be based on actual data. Although it is mentioned in References [26,27] that GRU and Bi-GRU are optimizations of LSTM, the results of this experimental data analysis cannot prove such a conclusion. GRU simplifies the structure of LSTM and accelerates operations, but its learning effect is not as good as LSTM. Bi-GRU learns the characteristics of time series from both forward and reverse directions, but learning from the reverse direction is far worse than from the forward direction. The experimental results of Bi-GRU are not as good as LSTM, and even worse than GRU.

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Data Availability Statement: The raw/processed data required to reproduce these findings cannot be shared at this time as the data also forms part of an ongoing study.

Conflicts of Interest: The authors declare no conflict of interest.

Abbreviations

HVDC	High voltage direct current
CNN	Convolutional neural network
LSTM	Long short-term memory
VMD	Variational mode decomposition
TEO	Teager energy operator
WT	Wavelet transform
HHT	Hilbert–Huang transform
VMD-TEO	Variational mode decomposition–Teager energy operator
EMD	Empirical mode decomposition
LIF	Low impedance fault
HIF	High impedance fault
RNN	Recurrent neural network
GRU	Gated recurrent unit
Bi-GRU	Bidirectional gated recurrent unit
IMF	Intrinsic mode function
IMF1	The first intrinsic mode function component
TEV	Teager energy value
VSC	Voltage source converter
NG	Negative ground
ELU	Exponential linear unit
PG	Positive ground
PN	Positive and negative

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